

LASER SPECTRUM ANALYZER

SA^{PLUS}

R&D AND MANUFACTURING—TRANSPORT AND DATACOM



Most precise laser spectral analysis available

- High spectral resolution with finesse greater than 300
- Choice of FSR for optimum performance with a variety of lasers
- Interchangeable mirrors for operation from 550 nm to 1.8 μm
- Programmable ramp generator to maximize measurement precision
- Automatic spectral analysis with optional Nuview software
- Optional fiber-optic coupling

High-Performance and Unparalleled Convenience

EXFO's SA^{Plus} Laser Spectrum Analyzer combines high performance laser spectral characterization and user-friendly design for the utmost precision, ease of use and convenience. The SA^{Plus} Laser Spectrum Analyzer is the best system available to measure the linewidth, longitudinal mode structure and frequency stability of narrow-band lasers.

FPS-250 Nuview turns a PC into a sophisticated oscilloscope-like device for completely automatic laser spectral analysis. Used with a Fabry-Perot interferometer-based laser spectrum analyzer, FPS-250 software conveniently measures spectral characteristics such as laser linewidth, longitudinal mode structure and frequency stability. The result is a better understanding of laser performance and therefore more meaningful experimental results.



HIGHEST FINESSE AVAILABLE

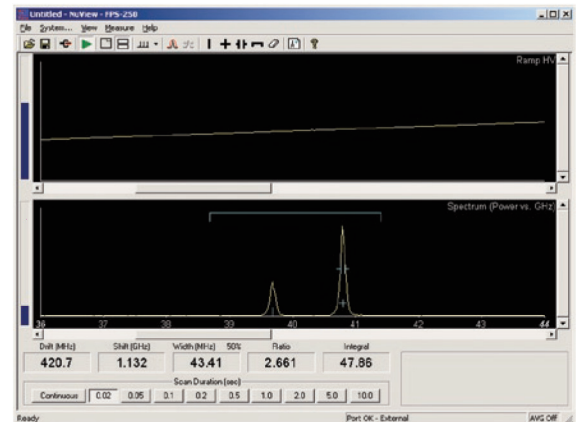
The SA^{Plus} Laser Spectrum Analyzer employs a piezoelectrically scanned confocal mirror Fabry-Perot interferometer to provide the finesse necessary to achieve high-resolution measurements. For wavelengths greater than 1000 nm, the SA^{Plus} is the only laser spectrum analyzer of its kind to guarantee a finesse of over 300. At shorter wavelengths, a finesse greater than 200 can be expected. The free spectral range of the SA^{Plus} system can be configured for either 2 or 8 GHz, depending on the application. The system can be reconfigured to a different free spectral range by simply changing the mirror set.

UNIQUE INTERCHANGEABLE MIRRORS

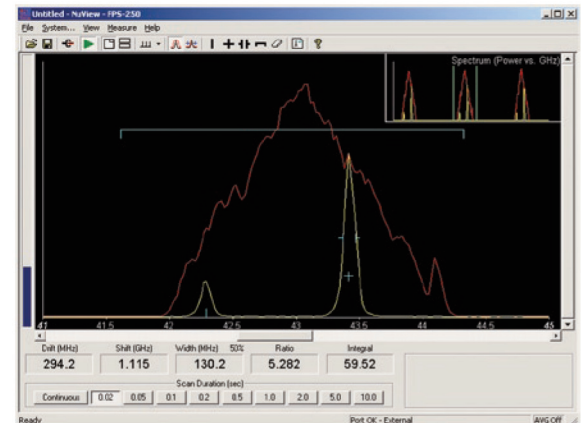
The SA^{Plus} Laser Spectrum Analyzer easily adapts as research interests change or expand to different spectral regions. Its unique mirror sets are easily replaced for operation anywhere between 550 nm and 1.8 μm . The confocal mirrors are supplied in Invar cells. Mounting is easy and requires no special tools. A high reflectivity (nominally 99.7%) multi-layer dielectric coating is applied to the concave surface of the mirrors. Hard coatings are used to maintain peak performance over the long lifetime of the mirrors.

EASY TO USE

The most exacting customers want optimal performance and ease of use. The SA^{Plus} Laser Spectrum Analyzer meets these standards with unique features that provide precise measurements with easy, straight forward adjustments. Accurate alignment is simple using a four-axis mount (X-Y- Θ - Φ) to position the interferometer's optical axis to the incoming laser beam. In addition, a convenient adjustment precisely sets the mirrors to their confocal separation, with the system completely assembled, so that finesse can be optimized by viewing the output signal. Features like these provide maximum performance within minutes, even after changing mirror sets.



Nuview spectrum display shows the spectral characteristics of a HeNe laser.



The storage feature is an effective method of measuring the frequency jitter of a laser.

KEY FEATURES

The Fabry-Perot interferometer is a simple device that relies on the interference of multiple beams. It consists of two partially transmitting mirrors that are precisely aligned to form a reflective cavity. Light enters the Fabry-Perot cavity and undergoes multiple reflections between the mirrors. If the frequency of the incident light is such that constructive interference occurs within the Fabry-Perot cavity, the light will be transmitted. Otherwise, destructive interference will not allow any light through the Fabry-Perot interferometer.

The constructive interference condition for a confocal mirror Fabry-Perot interferometer is defined by the equation

$$nd = m\lambda/4$$

where **m** is an integer termed the order of interference, **n** is the refractive index of the medium between the two mirrors, and **d** is the mirror separation.

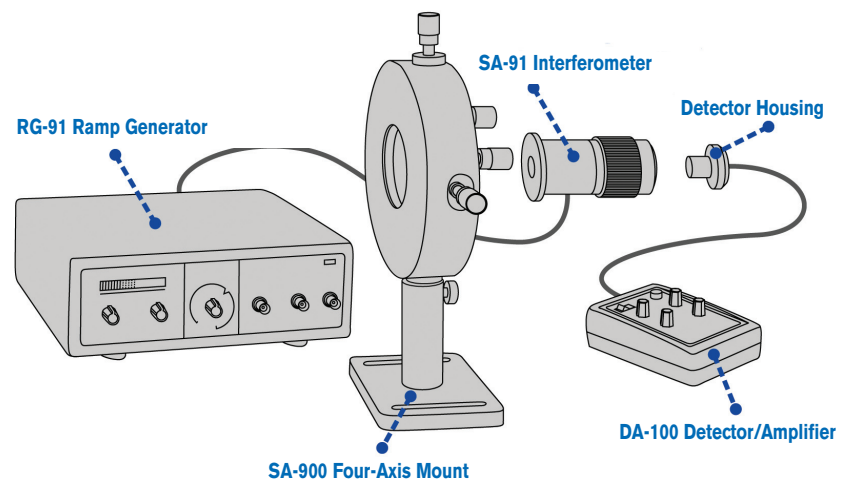
HIGH PERFORMANCE RAMP GENERATOR

The RG-91 is a single-channel ramp generator that provides the voltage required to piezo-electrically scan the interferometer of the SA^{Plus} Laser Spectrum Analyzer. This system provides convenient controls to adjust the range, zero offset and rate of the ramp voltage. In addition, the RG-91 Ramp Generator includes an adjustment to shape the ramp voltage in such a way as to correct for the inherent non-linear motion of the piezoelectric transducer. An external input also can be accepted for custom control of the interferometer in special applications.

HIGH SENSITIVITY DETECTOR/AMPLIFIER

The DA-100 Detector/Amplifier detects the laser light transmitted through the interferometer of the SA^{Plus} system, and then amplifies the signal for display. The photodetector is interchangeable for operation with the visible to the infrared wavelength ranges.

Its superior low noise performance detects signals as low as 1 nW in order to minimize the laser intensity required for laser spectral analysis. Convenient packaging and self-explanatory controls result in straightforward operation.



SPECIFICATIONS

SA^{Plus} Interferometer

Cavity design	Confocal mirror geometry
Free spectral range (FSR)	2 GHz or 8 GHz
Finesse	> 200 (for $\lambda < 1000$ nm) or > 300 (for $\lambda \geq 1000$ nm)
Minimum resolvable bandwidth	FSR/Finesse
Wavelength range	Standard ranges from 550 nm to 1.8 μ m
Mirror reflectivity	99.7 % nominal
Transmission	> 10 %
Input aperture	1 mm
PZT scan distance	1.2 μ m/1000 V
PZT non-linearity	< 1 %
Scan non-linearity	< 0.1 % with electronic compensation provided by the RG-91 Ramp Generator
Construction	Thermally stable Invar

DA-100 Detector Amplifier

Bandwidth	DC to 100 kHz (DC to 20 kHz @ maximum gain)
Sensitivity	0.1 V/mW to 1 V/ μ W, continuously variable
Minimum detectable power	Silicon -1 nW @ 633 nm, Germanium -2 nW @ 1.5 μ m
RMS noise	< 1 mV
Offset adjust	± 1 V
Output signal	0 to ± 6 V, 200 Ω impedance (polarity is invertible)
Dimensions and weight	
Dimensions (H x W x D)	57 mm x 89 mm x 152 mm (2 1/4 in x 3 1/2 in x 6 in)
Weight	0.45 kg (1 lb)
Power requirements	9 V battery

ORDERING INFORMATION

RG-91 Ramp Generator

Ramp voltage	
Amplitude	0 to 1000 V (continuously variable)
Bias	0 to 1000 V (continuously variable)
High voltage output	Amplitude + bias (1000 V maximum)
Current	4 mA maximum
RMS noise	< 30 mV
Duration	20 ms to 10 s (switch selectable)
Output slew rate	1 V/ μ s
Retrace	20 ms duration
External input	0 to 10 V (gain variable from 0 to 100)
Ramp non-linearity	0.25 % (10 - 90 %)
Output signals	
Blanking	0 V during ramp, -10 V during retrace
Output ± 100	0 to 10 V
Dimensions and weight	
Dimensions (H x W x D)	89 mm x 248 mm x 267 mm (3 1/2 in x 9 3/4 in x 10 1/2 in)
Weight	2.2 kg (5 lb)
Power requirements	100 to 240 VAC, 50/60 Hz

SA^{Plus} Accessories Available

FPS-250	Invar spacer set
SA-610	Fiber-optic coupler
BC-1	Input beam coupler
TJ-B89-89	FC/UPC to FC/UPC 9/125 μ m 3 m test jumper

ORDERING INFORMATION

(Mirror Set)

SA-92-XX

Model

SA-92-07	= 2 GHz free spectral range, 550-650 nm
SA-92-08	= 2 GHz free spectral range, 650-750 nm
SA-92-09	= 2 GHz free spectral range, 750-890 nm
SA-92-10	= 2 GHz free spectral range, 850-990 nm
SA-92-11	= 2 GHz free spectral range, 980-1145 nm
SA-92-12	= 2 GHz free spectral range, 1150-1345 nm
SA-92-13	= 2 GHz free spectral range, 1300-1550 nm
SA-92-14	= 2 GHz free spectral range, 1425-1675 nm
SA-92-15	= 2 GHz free spectral range, 1550-1800 nm

Example: SA-92-15

(Laser Spectrum Analyzer)

SA-PLUS-XX

Model

= SA-Plus-200-07
= SA-Plus-200-08
= SA-Plus-200-09
= SA-Plus-200-10
= SA-Plus-200-11
= SA-Plus-200-12
= SA-Plus-200-13
= SA-Plus-200-14
= SA-Plus-200-15

Example: SA-Plus-200-15

(Mirror Set)

SA-98-XX

Model

SA-98-07	= 8 GHz free spectral range, 550-650 nm
SA-98-08	= 8 GHz free spectral range, 650-750 nm
SA-98-09	= 8 GHz free spectral range, 750-890 nm
SA-98-10	= 8 GHz free spectral range, 850-990 nm
SA-98-11	= 8 GHz free spectral range, 980-1145 nm
SA-98-12	= 8 GHz free spectral range, 1150-1345 nm
SA-98-13	= 8 GHz free spectral range, 1300-1550 nm
SA-98-14	= 8 GHz free spectral range, 1425-1675 nm
SA-98-15	= 8 GHz free spectral range, 1550-1800 nm

Example: SA-98-15

(Laser Spectrum Analyzer)

SA-PLUS-XX

Model

= SA-Plus-800-07
= SA-Plus-800-08
= SA-Plus-800-09
= SA-Plus-800-10
= SA-Plus-800-11
= SA-Plus-800-12
= SA-Plus-800-13
= SA-Plus-800-14
= SA-Plus-800-15

Example: SA-Plus-800-15

Find out more about EXFO's extensive line of high-performance portable instruments by visiting our website at www.EXFO.com.

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EXFO is certified ISO 9001 and attests to the quality of these products. This device complies with Part 15 of the FCC Rules. Operation is subject to the following two conditions: (1) this device may not cause harmful interference, and (2) this device must accept any interference received, including interference that may cause undesired operation. EXFO has made every effort to ensure that the information contained in this specification sheet is accurate. All of EXFO's manufactured products are compliant with the European Union's WEEE directive. For more information, please visit www.EXFO.com/recycle. However, we accept no responsibility for any errors or omissions, and we reserve the right to modify design, characteristics and products at any time without obligation. Units of measurement in this document conform to SI standards and practices. Contact EXFO for prices and availability or to obtain the phone number of your local EXFO distributor.

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